



## Description

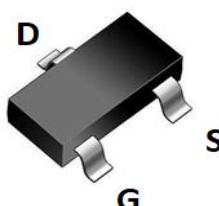
### JMT N-channel Enhancement Mode Power MOSFET

#### Features

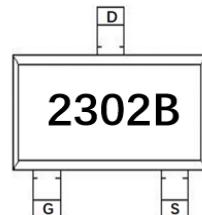
- 20V, 3A
- $R_{DS(ON)} < 61\text{m}\Omega$  @  $V_{GS} = 4.5\text{V}$
- $R_{DS(ON)} < 77\text{m}\Omega$  @  $V_{GS} = 2.5\text{V}$
- Advanced Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge
- Lead Free

#### Applications

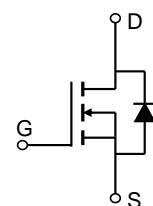
- Load Switch
- PWM Application
- Power Management



SOT-23 Top View



Marking and Pin Assignment



Schematic Diagram

#### Package Marking and Ordering Information

Device Marking	Device	Outline	Package	Reel Size	Reel(pcs)	Per Carton (pcs)
2302B	JMTL2302B	TAPING	SOT-23	7"	3000	120000

#### Absolute Maximum Ratings (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter		Value	Units
$V_{DS}$	Drain-to-Source Voltage		20	V
$V_{GS}$	Gate-to-Source Voltage		$\pm 12$	V
$I_D$	Continuous Drain Current	$T_A = 25^\circ\text{C}$	3	A
		$T_A = 100^\circ\text{C}$	2	
$I_{DM}$	Pulsed Drain Current <sup>(1)</sup>		12	A
$P_D$	Power Dissipation	$T_A = 25^\circ\text{C}$	1.2	W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient <sup>(2)</sup>		103	$^\circ\text{C}/\text{W}$
$T_J, T_{STG}$	Junction & Storage Temperature Range		-55 to 150	$^\circ\text{C}$

Electrical Characteristics ( $T_J = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	20	-	-	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	-	-	1.0	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 12\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.5	0.75	1.0	V
$R_{\text{DS(ON)}}$	Static Drain-Source ON-Resistance <sup>(3)</sup>	$V_{GS} = 4.5\text{V}, I_D = 3\text{A}$	-	47	61	$\text{m}\Omega$
		$V_{GS} = 2.5\text{V}, I_D = 2\text{A}$	-	59	77	$\text{m}\Omega$
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 10\text{V}, f = 1\text{MHz}$	-	200	-	pF
$C_{\text{oss}}$	Output Capacitance		-	35	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	28	-	pF
$Q_g$	Total Gate Charge	$V_{GS} = 0 \text{ to } 4.5\text{V}$ $V_{DD} = 10\text{V}, I_D = 2\text{A}$	-	3	-	nC
$Q_{gs}$	Gate Source Charge		-	0.5	-	nC
$Q_{gd}$	Gate Drain("Miller") Charge		-	0.7	-	nC
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{GS} = 4.5\text{V}, V_{DD} = 10\text{V}$ $I_D = 2\text{A}, R_{\text{GEN}} = 3\Omega$	-	3	-	ns
$t_r$	Turn-On Rise Time		-	11	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	20	-	ns
$t_f$	Turn-Off Fall Time		-	8	-	ns
<b>Drain-Source Diode Characteristics and Max Ratings</b>						
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	3	-	A
$I_{\text{SM}}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	12	-	A
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 3\text{A}$	-	-	1.2	V
$trr$	Body Diode Reverse Recovery Time	$I_F = 2\text{A}, di/dt = 100\text{A/us}$	-	4.3	-	ns
$Qrr$	Body Diode Reverse Recovery Charge		-	0.6	-	nC

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2.  $R_{\theta JA}$  is measured with the device mounted on a 1inch<sup>2</sup> pad of 2oz copper FR4 PCB3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$ .

## Typical Performance Characteristics

Figure 1: Output Characteristics

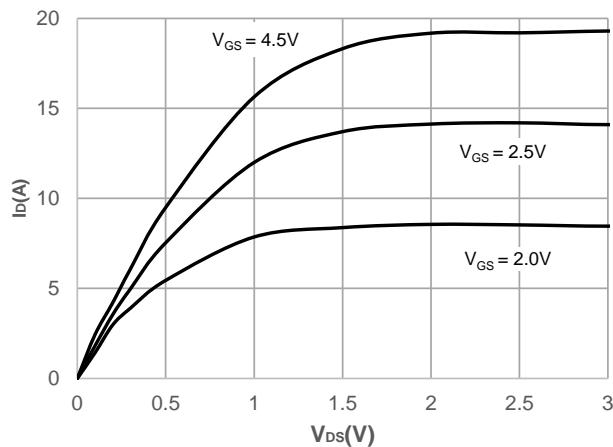


Figure 2: Typical Transfer Characteristics

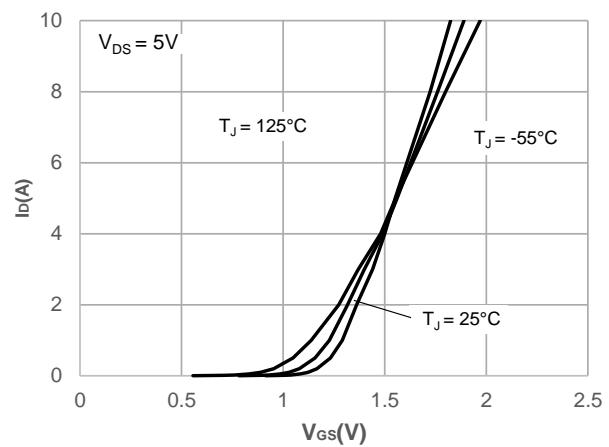


Figure 3: On-resistance vs. Drain Current

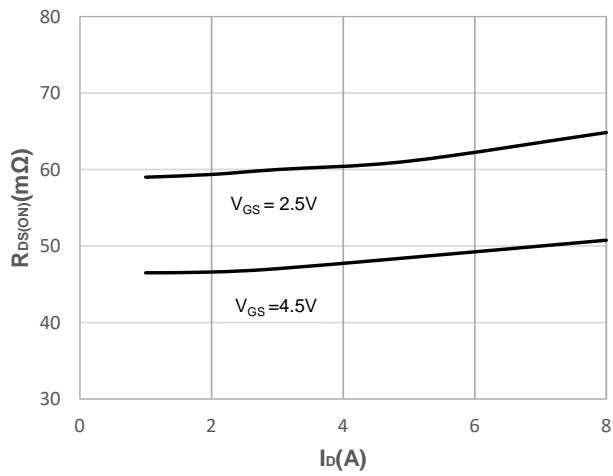


Figure 4: Body Diode Characteristics

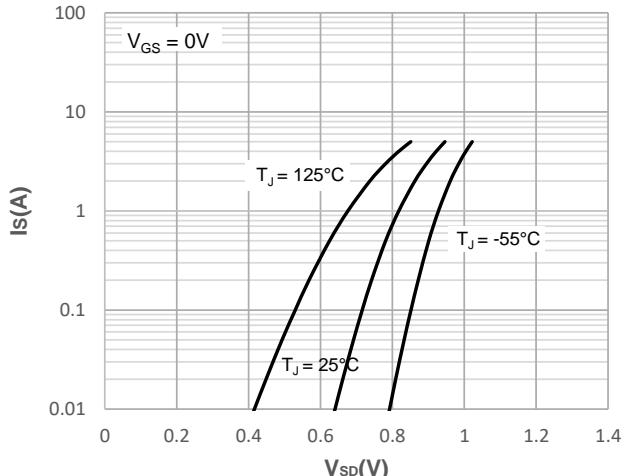


Figure 5: Gate Charge Characteristics

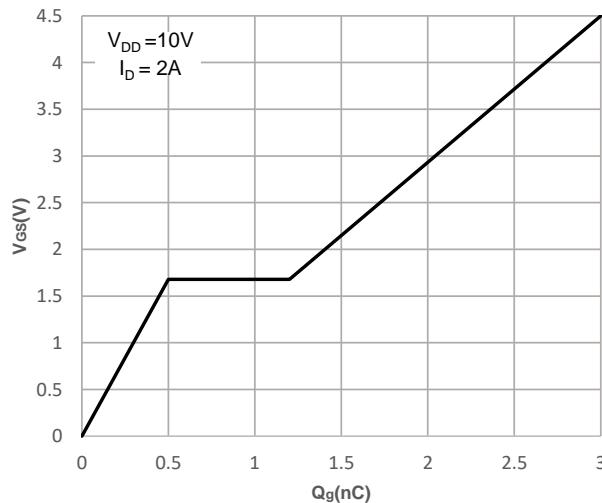
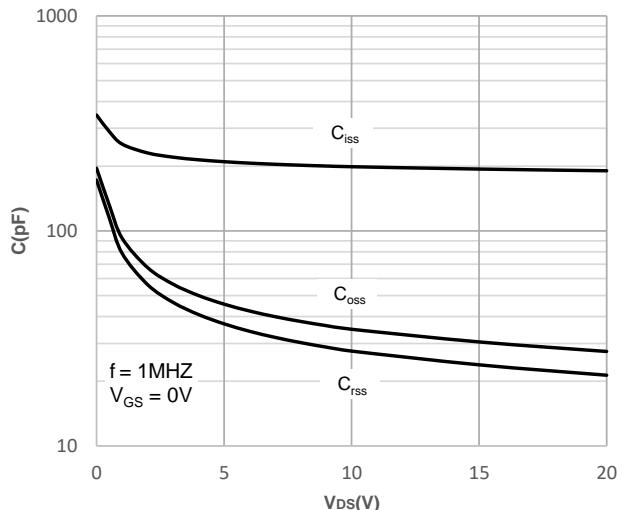
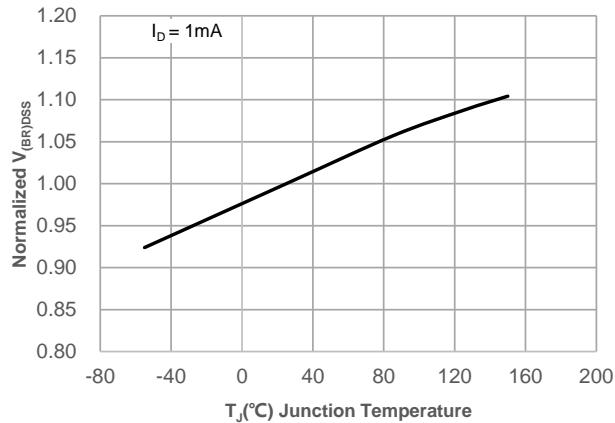


Figure 6: Capacitance Characteristics

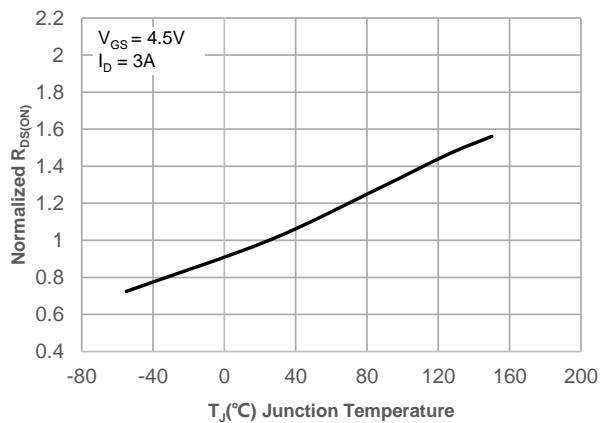


## Typical Performance Characteristics

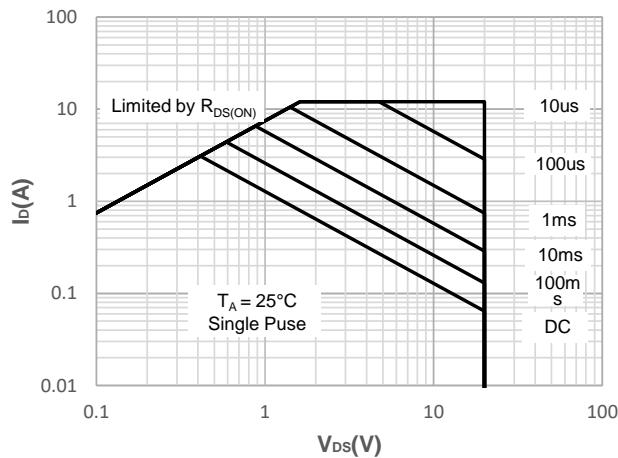
**Figure 7: Normalized Breakdown voltage vs. Junction Temperature**



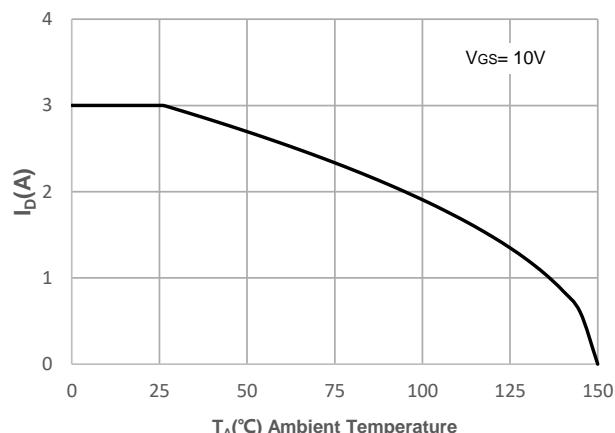
**Figure 8: Normalized on Resistance vs. Junction Temperature**



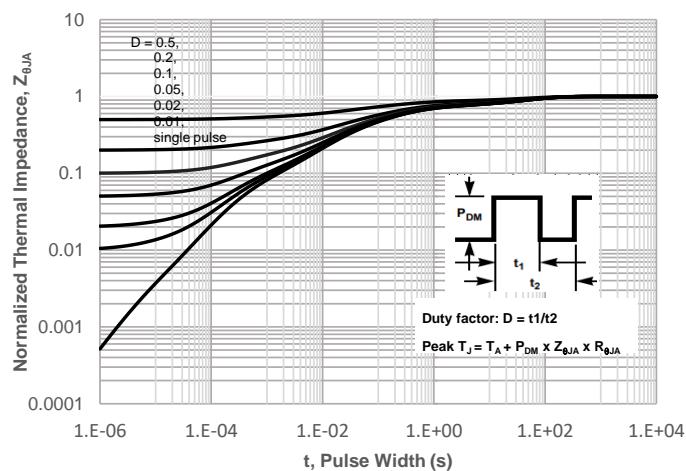
**Figure 9: Maximum Safe Operating Area**



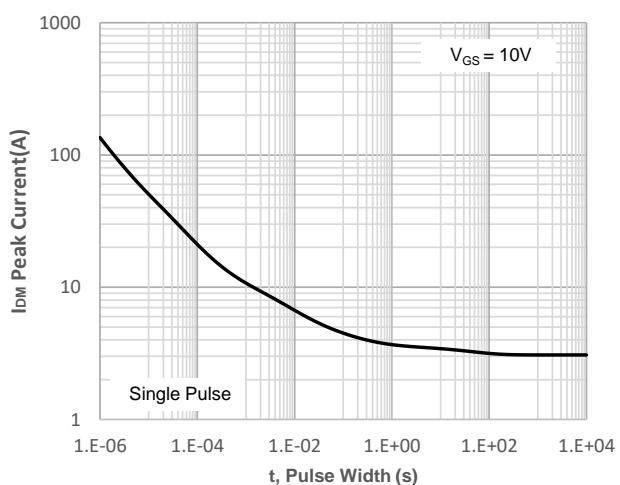
**Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature**



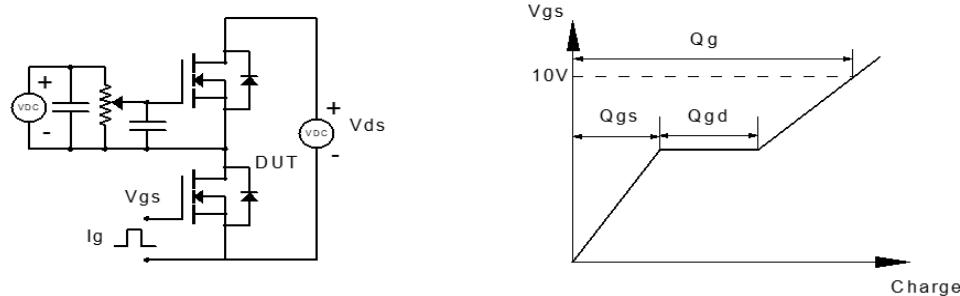
**Figure 11: Normalized Maximum Transient Thermal Impedance**



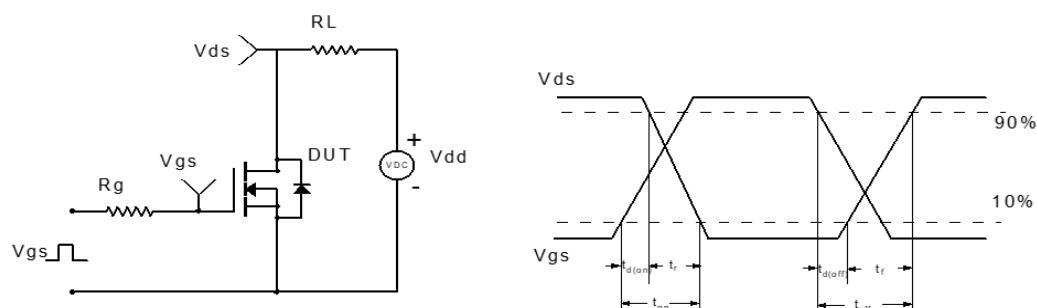
**Figure 12: Peak Current Capacity**



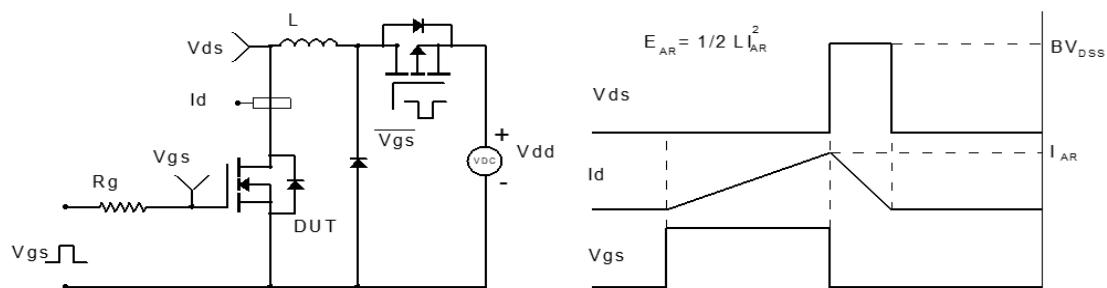
## Test Circuit



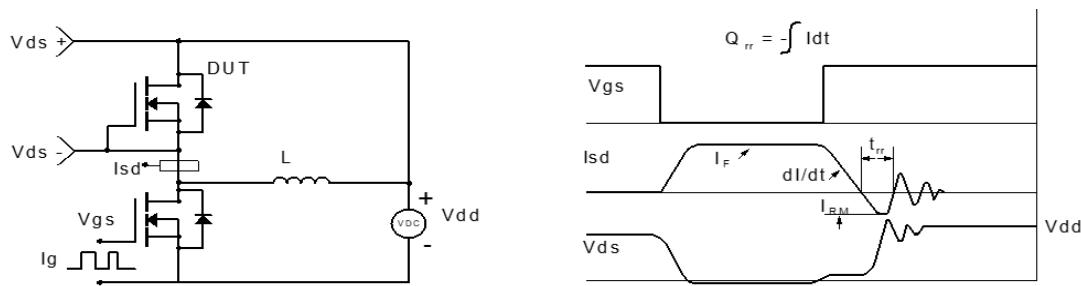
**Figure 1: Gate Charge Test Circuit & Waveform**



**Figure 2: Resistive Switching Test Circuit & Waveform**

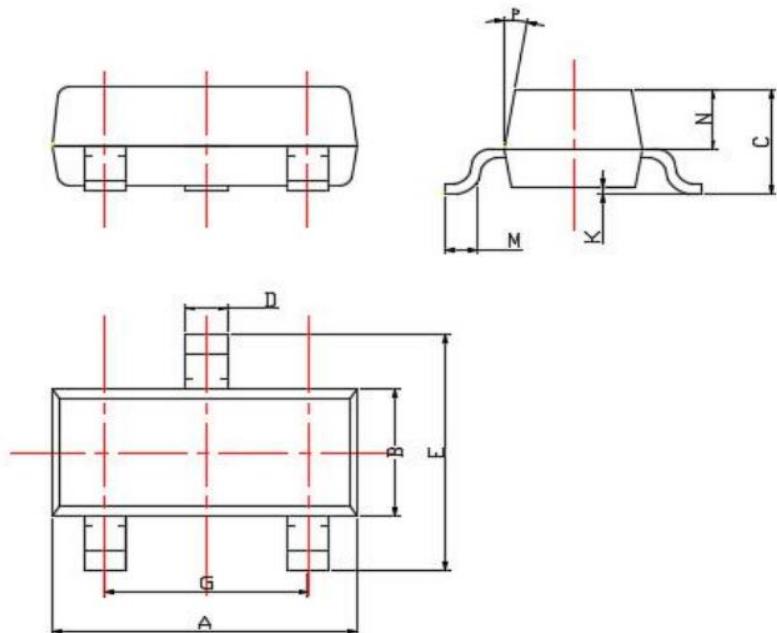


**Figure 3: Unclamped Inductive Switching Test Circuit & Waveform**



**Figure 4: Diode Recovery Test Circuit & Waveform**

## Package Mechanical Data(SOT-23)



DIM	MILLIMETERS
A	2.85~3.04
B	1.30 ± 0.10
C	1.00 ± 0.10
D	0.45 ± 0.05
E	2.25~2.55
G	1.90 ± 0.1
K	0.00~0.10
M	0.20 MIN
N	0.60 ± 0.10
P	7 ± 2°

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